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Sheet 1 of 2 FORM PTO-1449 US DEPARTMENT OF COMMERCE Airy. Docket No. Serial No. 85377LMB PATENT AND TRADEMARK OFFICE Customer No. 01333 If AFTER the later date of the first Office Action Annlicant: Peter T. Aylward, et al or 3 months from filing, use only with Rule 97(E) Certificate or Fee LIST OF ART CITED BY APPLICANT Filing Date Group 2-27-0 1752 (Use several sheets if necessary) **U.S. PATENT DOCUMENTS** DOCUMENT NUMBER . DATE CLASS SUBCLASS FILING DATE Initial IF APPROPRIATE 3,299,192 01-17-1967 John H. Lux M 3,864,444 02-04-1975 **Johnson** 4,098,941 07-04-1978 Johnson Johnson 4,456,571 06-26-1984 4,832,775 05-23-1989 Park et al. 5,084,334 01-28-1992 Hamano et al. 5,277,852 01-11-1994 Spydevold 5,667,740 Spydevold 07-16-1997 Morita 5,674,442 10-07-1997 12-22-1998 Chao 5,851,651 5,866,282 02-02-1999 Bourdelais et al. 6,077,065 06-20-2000 Sumiyoshi et al. 6,447,976 B1 09-10-2002 Dontula et al. 6,514,659 B1 02-04-2003 Dontula et al. 6,514,660 B1 02-04-2003 Majumdar et al. 6,537,656 B1 03-25-2003 Dontual et al. 05-20-2003 Majumdar et al. 6,566,033 B1 2003/0031747 A1 02-13-2003 Becker 2003/0031748 A1 02-13-2003 Becker 2003/0036479 A1 02-20-2003 Maiumdar et al. 2003/0073577 A1 04-17-2003 Majumdar et al. 2003/0118750 A1 06-26-2003 Bourdelais et al. 2003/0118807 A1 06-26-2003 Laney et al. 2003/0123150 A1 07-03-2003 Brickey et al. 2003/0128313 A1 07-10-2003 Kaminsky et al. 2003/0152760 A1 08-14-2003 Lai et al. 2003/0219610 A1 11-27-2003 Aylward et al. 2003/0219663 A1 11-27-2003 Sunderrajan et al. 2003/0232188 A1 12-18-2003 Savage et al. FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER SUBCLASS Examiner DATE COUNTRY CLASS TRANSLATION Initial* YES ſ'n 1 285 741 A1 02-26-2003 EP Х 0 838 321 B1 12-10-2003 EP X 2839905 B2 12-24-1998 JP X JP X 3308733 B2 07/29/2002

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EXAMINER R 1 Schillen	DATE CONSIDERED Y SOCK		
*EXAMINER: Initial if reference considered, whether fr not cifation is in conformance with MPEP 609; Draw line through citation if not in conformance			
and not considered. Include copy of this form with next communication to applicant.			